



SamHop Microelectronics Corp.

S DM9433

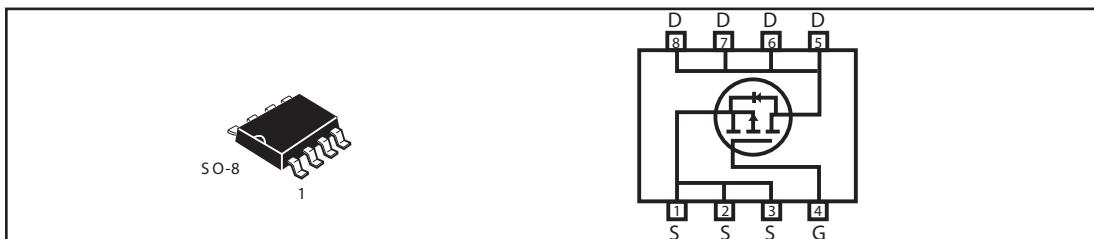
March , 2003

P-Channel Enhancement Mode MOSFET

PRODUCT SUMMARY		
V _{DSS}	I _D	R _{DS(ON)} (mΩ) MAX
-20V	-5.4A	45 @ V _{GS} = -4.5V
		70 @ V _{GS} = -2.7V

FEATURES

- Super high dense cell design for low R_{DS(ON)}.
- Rugged and reliable.
- Surface Mount Package.



ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-20	V
Gate-Source Voltage	V _{GS}	±12	V
Drain Current-Continuous ^a @ T _J =125°C -Pulsed ^b	I _D	±5.4	A
	I _{DM}	±20	A
Drain-Source Diode Forward Current ^a	I _S	2.6	A
Maximum Power Dissipation ^a	P _D	2.5	W
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient ^a	R θ_{JA}	50	°C/W
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ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-20			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -16V, V_{GS} = 0V$		-1		μA
Gate-Body Leakage	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$		± 100		nA
ON CHARACTERISTICS^b						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.7			V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS} = -4.5V, I_D = -5.1A$		45		m-ohm
		$V_{GS} = -2.7V, I_D = -2.0A$		70		m-ohm
On-State Drain Current	$I_{D(ON)}$	$V_{DS} = -5V, V_{GS} = -4.5V$	-20			A
Forward Transconductance	g_{FS}	$V_{DS} = -15V, I_D = -5.3A$		13		S
DYNAMIC CHARACTERISTICS^c						
Input Capacitance	C_{iss}	$V_{DS} = -10V, V_{GS} = 0V$ $f = 1.0MHz$		1190		pF
Output Capacitance	C_{oss}			710		pF
Reverse Transfer Capacitance	C_{rss}			260		pF
SWITCHING CHARACTERISTICS^c						
Turn-On Delay Time	$t_{D(ON)}$	$V_D = -10V,$ $I_D = -1A,$ $V_{GEN} = -4.5V,$ $R_{GEN} = 6\text{-}\Omega$		20	40	ns
Rise Time	t_r			18	70	ns
Turn-Off Delay Time	$t_{D(OFF)}$			50	120	ns
Fall Time	t_f			29	140	ns
Total Gate Charge	Q_g	$V_{DS} = -10V, I_D = -1A,$ $V_{GS} = -4.5V$		20	25	nC
Gate-Source Charge	Q_{gs}			4		nC
Gate-Drain Charge	Q_{gd}			4.3		nC

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ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS ^b						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0V, I_S = -5.3A$		-0.89	-1.2	V

Notes

- a. Surface Mounted on FR4 Board, $t \leq 10\text{sec}$.
- b. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
- c. Guaranteed by design, not subject to production testing.

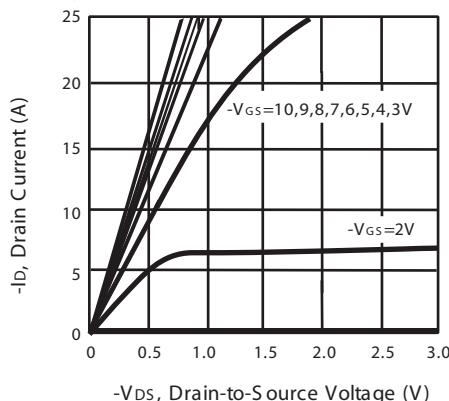


Figure 1. Output Characteristics

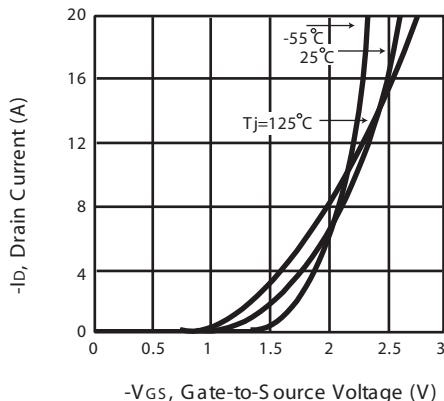


Figure 2. Transfer Characteristics

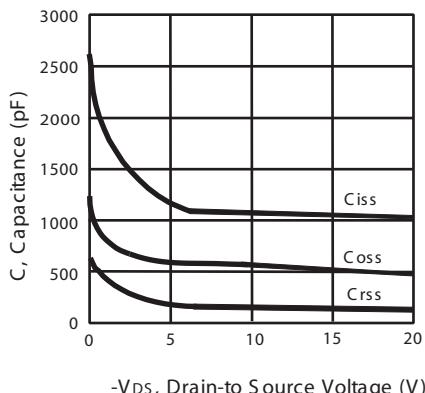


Figure 3. Capacitance

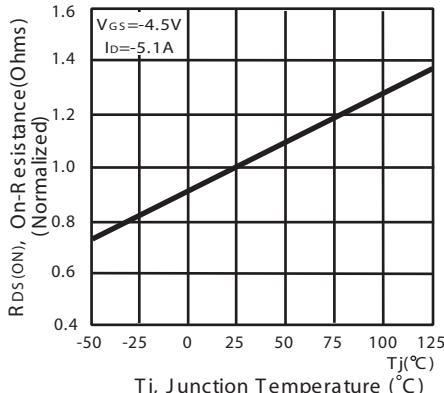
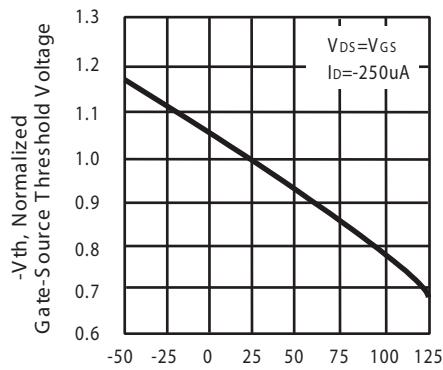


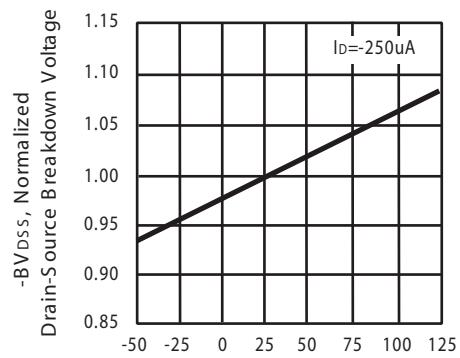
Figure 4. On-Resistance Variation with Temperature

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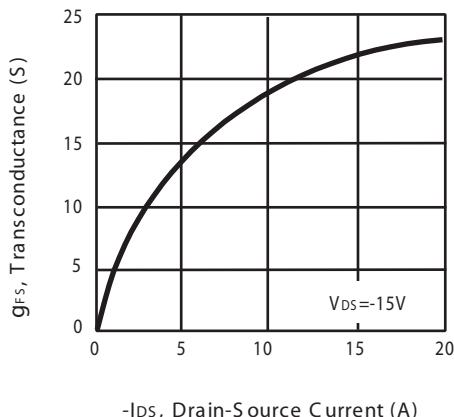
T_j , Junction Temperature (°C)

Figure 5. Gate Threshold Variation with Temperature



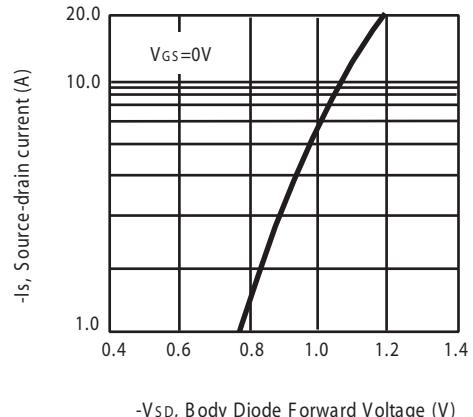
T_j , Junction Temperature (°C)

Figure 6. Breakdown Voltage Variation with Temperature



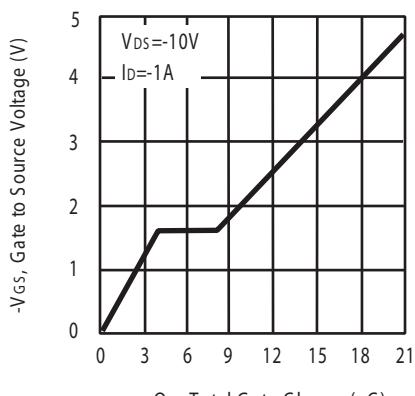
$-IDS$, Drain-Source Current (A)

Figure 7. Transconductance Variation with Drain Current



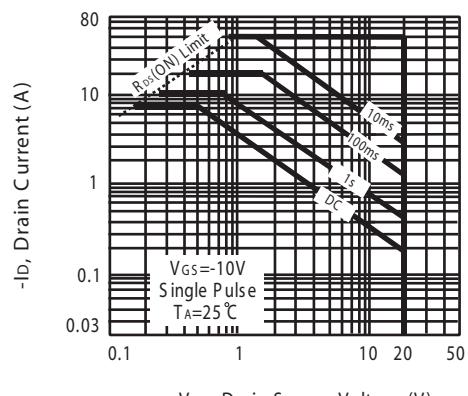
$-V_{SD}$, Body Diode Forward Voltage (V)

Figure 8. Body Diode Forward Voltage Variation with Source Current



Q_g , Total Gate Charge (nC)

Figure 9. Gate Charge



$-V_{DS}$, Drain-Source Voltage (V)

Figure 10. Maximum Safe Operating Area

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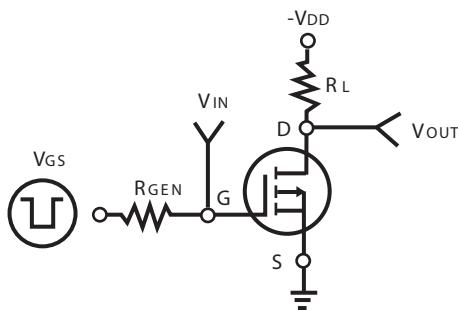


Figure 11. S switching Test Circuit

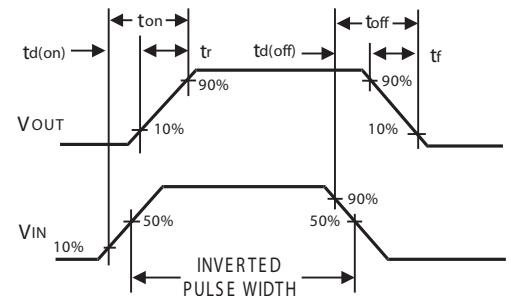


Figure 12. S switching Waveforms

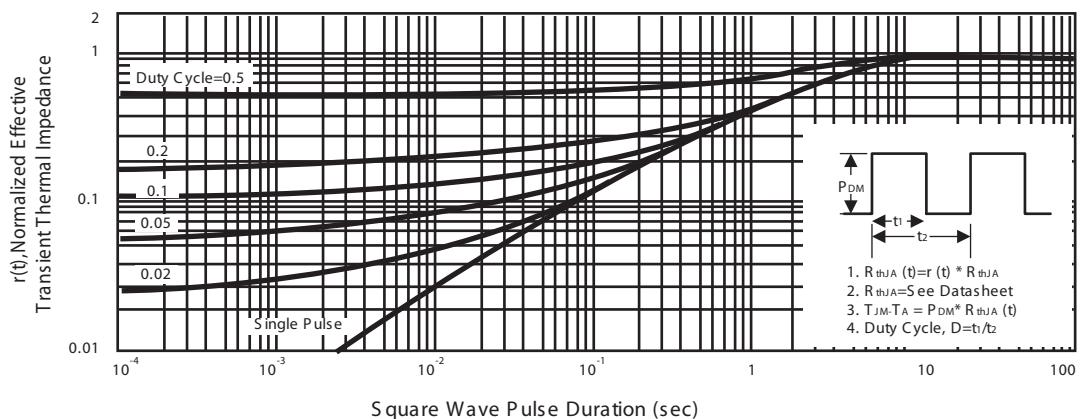


Figure 13. Normalized Thermal Transient Impedance Curve